Electronic Supporting Information

Improvement in the thermoelectric performance of highly reproducible *n*-

type (Bi,Sb)₂Se₃ alloys by Cl-doping

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1. The lattice parameters of Cl-doped BiSbSe₃.

Figure S1. (a) One typical XRD refinement result of $BiSbSe_3$ sample. (b) The change in lattice parameters (*a*, *b*, and *c*) of orthorhombic $BiSbSe_3$ by Cl-doping.

2. Microstructure analysis for the SPSed BiSbSe_{3-y}Cl_y (y = 0, 0.12, 0.18, 0.24) and Bi_{1.2}Sb_{0.8}Se_{3-z}Cl_z (z = 0, 0.12, 0.18, 0.24) samples.



Figure S2. SEM images of fractured surfaces for the SPSed BiSbSe_{3-y}Cl_y (y = 0, 0.12, 0.18, 0.24) and Bi_{1.2}Sb_{0.8}Se_{3-z}Cl_z (z = 0, 0.12, 0.18, 0.24).

3. The mole fraction of rhombohedral phase in $Bi_{1,2}Sb_{0.8}Se_{3-z}Cl_z$ (z = 0, 0.12, 0.18, 0.24). Table S1. The mole fraction of rhombohedral phase in $Bi_{1,2}Sb_{0.8}Se_{3-z}Cl_z$ (z = 0, 0.12, 0.18, 0.24), which is calculated by Rietveld refinement. The relative densities of the samples measured by the Archimedes principle (AlfaMiracle, MD-300S) are also shown.

| Compositions (nominal) | Mole fraction | | Delative density (9/) |
|---|---------------|--------------|-----------------------|
| | Rhombohedral | Orthorhombic | Relative density (%) |
| $Bi_{1.2}Sb_{0.8}Se_3$ | 0.743 | 0.257 | 97.4% |
| Bi _{1.2} Sb _{0.8} Se _{2.88} Cl _{0.12} | 0.744 | 0.256 | 97.4% |
| Bi _{1.2} Sb _{0.8} Se _{2.82} Cl _{0.18} | 0.745 | 0.255 | 95.5% |
| Bi _{1.2} Sb _{0.8} Se _{2.76} Cl _{0.24} | 0.747 | 0.253 | 97.1% |





Figure S3. (a) One typical XRD refinement result of $Bi_{1,2}Sb_{0,8}Se_3$ sample. (b) The change in lattice parameters of rhombohedral (*a* and *c*) and orthorhombic (*a*, *b*, and *c*) phases of $Bi_{1,2}Sb_{0,8}Se_3$ by Cl-doping.

5. Phase formation in Bi_{1.2}Sb_{0.8}Se_{2.7}Cl_{0.3}.



Figure S4. XRD pattern of SPSed Bi_{1.2}Sb_{0.8}Se_{2.7}Cl_{0.3}.

6. Calculation of electronic thermal condutivity

The electronic thermal conductivity (κ_{ele}) is estimated by the Wiedemann-Franz law ($\kappa_{ele} = L\sigma T$, where *L*, σ , and *T* are the Lorenz number, electrical conductivity, and the absolute temperature). Temperature dependent *L* is obtained by using Eq. S1 assuming a single parabolic band model [1].

$$L = 1.5 + \exp\left(-\frac{|S|}{116}\right) \tag{S1}$$

Figure S5 shows the temperature dependences of L for Cl-doped BiSbSe₃ and Bi_{1.2}Sb_{0.8}Se₃.



Figure S5. Temperature dependences of L for Cl-doped BiSbSe₃ and $Bi_{1,2}Sb_{0,8}Se_3$.

References

[1] H. S. Kim, Z. M. Gibbs, Y. Tang, H. Wang, and G. J. Snyder, APL Mater. 3 (2015) 041506.